## International Rectifier

### POWER MOSFET THRU-HOLE (MO-036AB)

**Product Summary** 

Part Number	RDS(on)	ΙD
IRFG110	0.7 Ω	1.0A

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

# IRFG110 JANTX2N7334 JANTXV2N7334 REF:MIL-PRF-19500/597 100V, QUAD N-CHANNEL HEXFET® MOSFETTECHNOLOGY



#### Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light-weight

#### **Absolute Maximum Ratings**

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	1.0	
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	0.6	Α
IDM	Pulsed Drain Current ①	4.0	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Max. Power Dissipation	1.4	W
	Linear Derating Factor	0.011	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	75	mJ
IAR	Avalanche Current ①	_	Α
EAR	Repetitive Avalanche Energy ①	_	mJ
dv/dt	Peak Diode Recovery dv/dt 3	5.5	V/ns
ТЈ	Operating Junction	-55 to 150	
TSTG Storage Temperature Range			°C
	Lead Temperature	300 (0.63 in./1.6 mm from case for 10s)	
	Weight	1.3 (Typical)	g

For footnotes refer to the last page

#### Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	100	_	_	V	VGS = 0V, ID = 1.0mA
ΔBVDSS/ΔTJ	Temperature Coefficient of Breakdown Voltage	_	0.13	_	V/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA
RDS(on)	Static Drain-to-Source On-State	_	_	0.7	Ω	VGS = 10V, ID = 0.6A
	Resistance	_	_	0.8	22	VGS = 10V, ID = 1.0A
VGS(th)	Gate Threshold Voltage	2.0	_	4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA
9fs	Forward Transconductance	0.86	_	_	S (7)	V <sub>DS</sub> > 15V, I <sub>DS</sub> = 0.6A ④
IDSS	Zero Gate Voltage Drain Current	_	_	25	μΑ	VDS= 80V ,VGS=0V
		_	_	250	μΑ	V <sub>DS</sub> = 80V,
						VGS = 0V, TJ = 125°C
IGSS	Gate-to-Source Leakage Forward	_	_	100	^	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse	_	_	-100	nA	Vgs = -20V
Qg	Total Gate Charge	_	_	15		VGS =10V, ID = 1.0A
Qgs	Gate-to-Source Charge	_	_	7.5	nC	V <sub>DS</sub> = 50V
Q <sub>gd</sub>	Gate-to-Drain ('Miller') Charge	_	_	7.5		
<sup>t</sup> d(on)	Turn-On Delay Time		_	20		$V_{DD} = 50V, I_{D} = 1.0A,$
tr	Rise Time	_	l —	25		$V_{GS} = 10V, R_{G} = 7.5\Omega$
<sup>t</sup> d(off)	Turn-Off Delay Time	_	_	40	ns	
tf	Fall Time	_	_	40		
Ls+LD	Total Inductance	_	10	_	nΗ	Measured from drain lead (6mm/ 0.25in. from package) to source lead (6mm/0.25in. from package)
C <sub>iss</sub>	Input Capacitance		180	_		VGS = 0V, VDS = 25V
Coss	Output Capacitance	_	82	_	pF	f = 1.0MHz
C <sub>rss</sub>	Reverse Transfer Capacitance	_	15	_	I	

#### **Source-Drain Diode Ratings and Characteristics**

	Parameter		Min	Тур	Max	Units	Test Conditions
Is	Continuous Source Current (	(Body Diode)	_	_	1.0		
ISM	Pulse Source Current (Body	Diode) ①	_	_	4.0	Α	
VSD	Diode Forward Voltage		_	_	1.5	V	$T_j = 25^{\circ}C$ , $I_S = 1.0A$ , $V_{GS} = 0V$ ④
t <sub>rr</sub>	Reverse Recovery Time		_	_	200	nS	$T_j$ = 25°C, $I_F$ = 1.0A, $di/dt$ ≤ 100A/μs
QRR	Reverse Recovery Charge		_	_	0.83	μC	V <sub>DD</sub> ≤ 50V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by Lg + LD.					

#### **Thermal Resistance**

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	-	_	17	°C/W	
R <sub>th</sub> JA	Junction-to-Ambient		_	90	C/VV	Typical socket mount

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

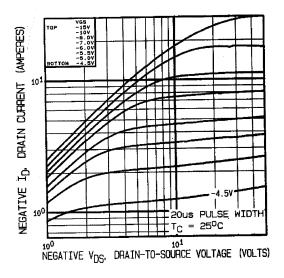


Fig 1. Typical Output Characteristics

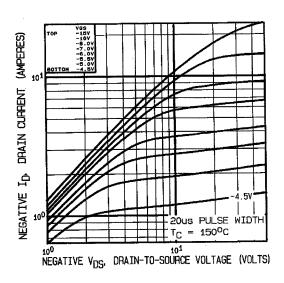


Fig 2. Typical Output Characteristics

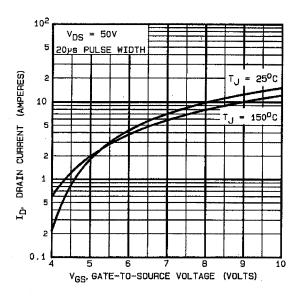
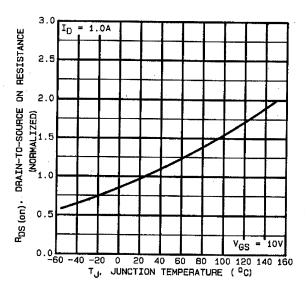
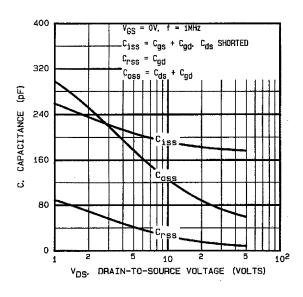


Fig 3. Typical Transfer Characteristics

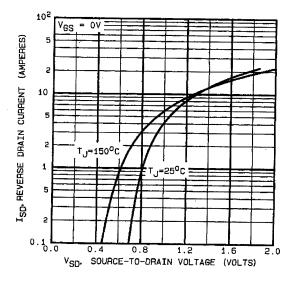


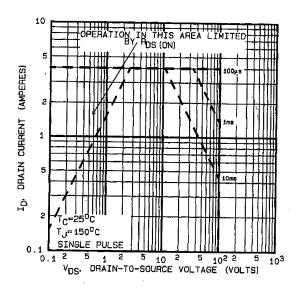
**Fig 4.** Normalized On-Resistance Vs. Temperature



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

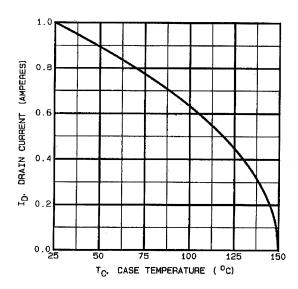
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage





**Fig 7.** Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs. Case Temperature

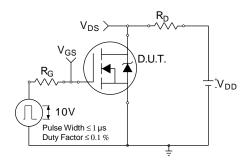


Fig 10a. Switching Time Test Circuit

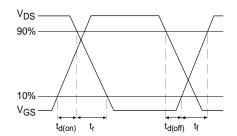


Fig 10b. Switching Time Waveforms

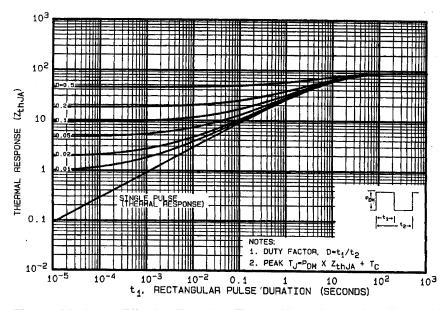


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

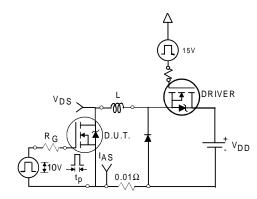


Fig 12a. Unclamped Inductive Test Circuit

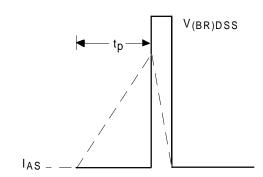


Fig 12b. Unclamped Inductive Waveforms

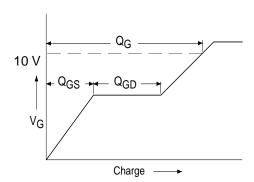
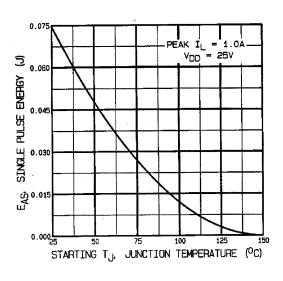


Fig 13a. Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

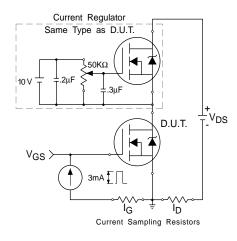


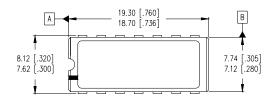
Fig 13b. Gate Charge Test Circuit

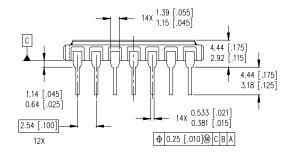


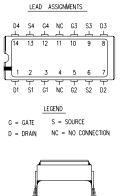
#### Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\circ}$  V<sub>DD</sub> = 25V, starting T<sub>J</sub> = 25°C, L= 150mH Peak I<sub>L</sub> = 1.0A, V<sub>GS</sub> = 10V
- $\label{eq:local_state} \begin{tabular}{ll} \begin{tabular}{ll}$
- 4 Pulse width  $\leq 300 \ \mu s$ ; Duty Cycle  $\leq 2\%$

#### Case Outline and Dimensions — MO-036AB









#### NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4. OUTLINE CONFORMS TO JEDEC OUTLINE MO-036AB.
- MEASURED WITH THE LEADS CONSTRAINED TO BE PERPENDICULAR TO DATUM PLANE C.

## International Rectifier

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Data and specifications subject to change without notice. 04/02